

<b>Notice of References Cited</b>		Application/Control No. 10/792,092	Applicant(s)/Patent Under Reexamination PAILA ET AL.	
		Examiner KENAN CEHIC	Art Unit 2616	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,182,147 B1	01-2001	Farinacci, Dino	709/238
*	B	US-6,243,758 B1	06-2001	Okanoue, Kazuhiro	709/238
*	C	US-2002/0073086 A1	06-2002	Thompson et al.	707/10
*	D	US-2002/0143951 A1	10-2002	Khan et al.	709/227
*	E	US-2002/0191584 A1	12-2002	Korus et al.	370/349
*	F	US-2003/0061333 A1	03-2003	Dean et al.	709/223
*	G	US-2005/0063352 A1	03-2005	Amara et al.	370/338
*	H	US-2005/0283447 A1	12-2005	Xu et al.	705/400
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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